

# FH38P03G6

## P-Channel Enhancement Mode MOSFET

### Description

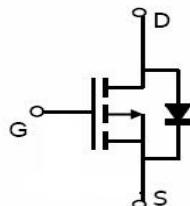
The FH38P03G6 is the P-Channel enhancement mode MOSFET in a plastic package (PDFN3.3x3.3-8L) using the Trench technology.

### Applications

- ◆ High Speed Switch
- ◆ DC-DC Converters
- ◆ Lithium-Ion Battery

### Features

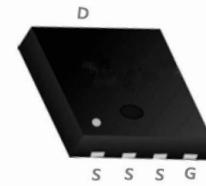
- ◆  $V_{DS} = -30V$ ;  $I_D = -38A$
- ◆  $R_{DS(ON)}(\text{Typ.}) = 8.5\text{ m}\Omega$  @  $V_{GS} = -10V$
- ◆  $R_{DS(ON)}(\text{Typ.}) = 11\text{ m}\Omega$  @  $V_{GS} = -4.5V$
- ◆ Logic Level Compatible
- ◆ SMD Package (PDFN3.3x3.3-8L)
- ◆ Trench Technology
- ◆ Fast Switching



Schematic diagram



Marking and Pin Assignment



PDFN3.3x3.3-8L top view

### Absolute Maximum Ratings ( $T_A = 25^\circ C$ , unless otherwise specified)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current ( $T_C = 25^\circ C$ )	$I_D$	-38	A
Pulsed Drain Current (Note 3)	$I_{DM}$	-100	A
Power Dissipation	$P_D$	31	W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C
Thermal Resistance-Junction to Ambient (Note 1)	$R_{thJA}$	80	°C/W

## ■ Electrical Characteristics ( $T_A = 25^\circ\text{C}$ , unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>Static</b>						
Drain-source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = -250\mu\text{A}$	-30	-34	-	V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = -250\mu\text{A}$	-1.1	-1.5	-1.9	V
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = -30\text{V}, V_{\text{GS}} = 0\text{V}$	-	-	-1	$\mu\text{A}$
Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = -10\text{V}, I_{\text{D}} = -10\text{A}$	-	8.5	11	$\text{m}\Omega$
		$V_{\text{GS}} = -4.5\text{V}, I_{\text{D}} = -8.0\text{A}$	-	11	14	
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}} = -5\text{V}, I_{\text{D}} = -5.0\text{A}$	-	15		S
Diode Forward Voltage <b>(Note 2)</b>	$V_{\text{SD}}$	$V_{\text{GS}} = 0\text{V}, I_{\text{S}} = -1.0\text{A}$	-	-	-1.2	V
Diode Forward Current <b>(Note 1)</b>	$I_{\text{S}}$		-	-	-10	A
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{\text{DS}} = -15\text{V}, V_{\text{GS}} = -10\text{V}, I_{\text{D}} = -1\text{A}$	-	45	-	$\text{nC}$
Gate-Source Charge	$Q_{\text{gs}}$		-	5	-	
Gate-Drain Charge	$Q_{\text{gd}}$		-	4	-	
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}} = -15\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$	-	1970	-	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		-	250	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	164	-	
<b>Switching</b>						
Turn-On Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}} = -15\text{V}, R_{\text{L}} = 15\Omega, I_{\text{D}} = -1\text{A}, V_{\text{GS}} = -4.5\text{V}, R_{\text{GEN}} = 10\Omega$	-	9	-	$\text{nS}$
Rise Time	$t_r$		-	5	-	
Turn-Off Delay Time	$t_{\text{d(off)}}$		-	38	-	
Fall-Time	$t_f$		-	11	-	

- Note:
1. Mounted on FR4 board,  $t \leq 5\text{sec}$ .
  2. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
  3. Repetitive Rating: Pulse width limited by maximum junction temperature.

## ■ Typical Electrical and Thermal Characteristics

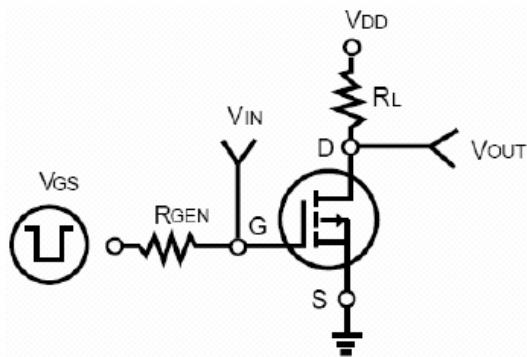


Figure 1: Switching Test Circuit

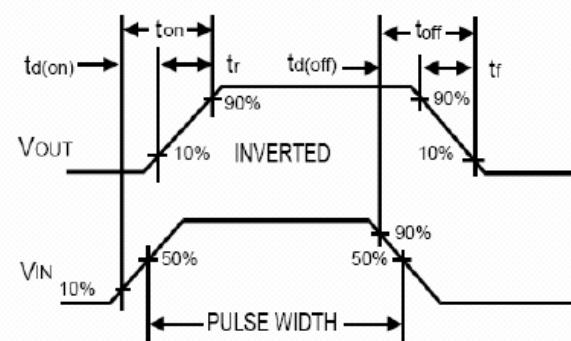


Figure 2: Switching Waveforms

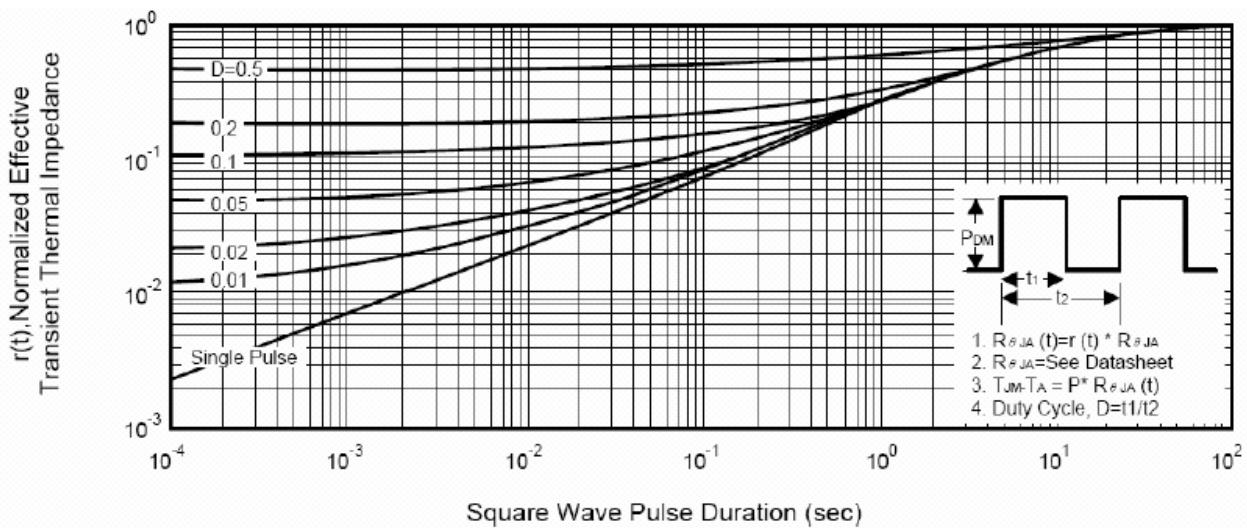
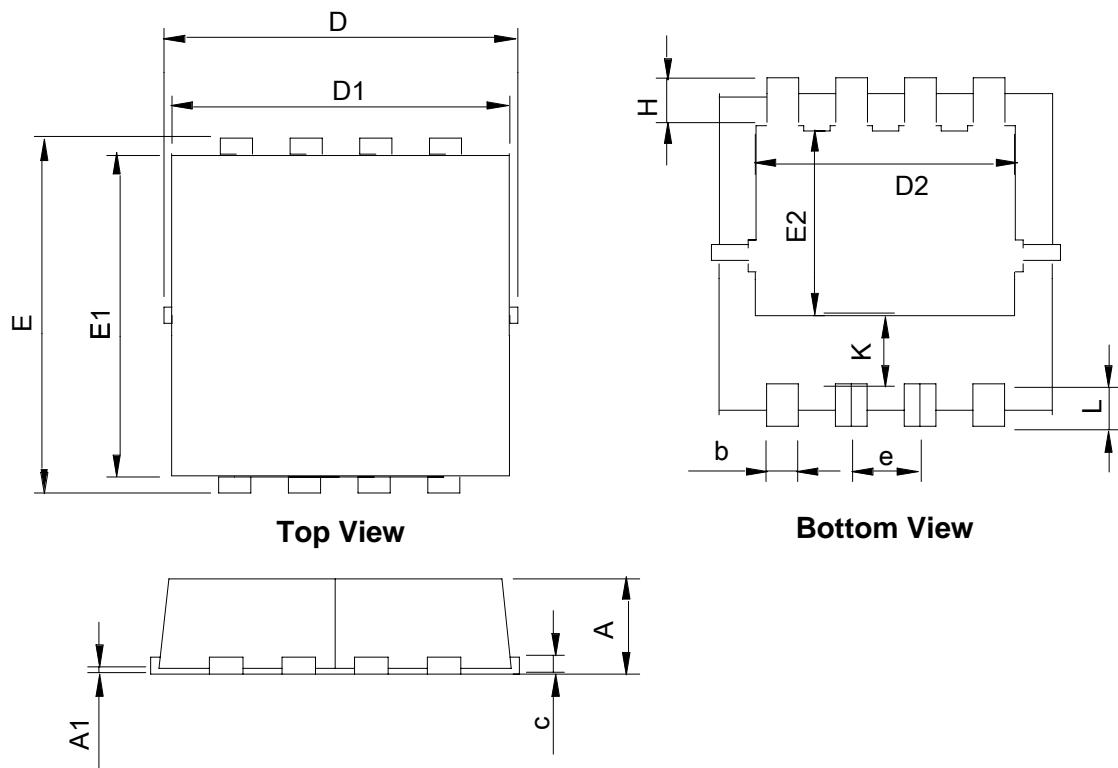


Figure 3: Normalized Maximum Transient Thermal Impedance

**■ Package Dimensions : PDFN3.3x3.3-8L**

SYMBOL	PDFN3.3x3.3-8L			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.00	0.028	0.039
A1	0.00	0.05	0.000	0.002
b	0.25	0.35	0.010	0.014
c	0.14	0.20	0.006	0.008
D	3.10	3.50	0.122	0.138
D1	3.05	3.25	0.120	0.128
D2	2.35	2.55	0.093	0.100
E	3.10	3.50	0.122	0.138
E1	2.90	3.10	0.114	0.122
E2	1.64	1.84	0.065	0.072
e	0.65 BSC		0.026 BSC	
H	0.32	0.52	0.013	0.020
K	0.59	0.79	0.023	0.031
L	0.25	0.55	0.010	0.022